## Notice of References Cited Application/Control No. 10/668,356 Examiner Thuy V. Tran Applicant(s)/Patent Under Reexamination MIN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0057238 A1	05-2002	Nitta et al.	345/87
*	В	US-6,707,264	03-2004	Lin et al.	315/307
*	С	US-6,501,234	12-2002	Lin et al.	315/307
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-		·	
	J	US-			
	К	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			•		
	Q					
	R					
	s					
	Τ					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	8	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.